

**INFORMATION DISCLOSURE  
CITATION**

Atty. Docket No.: D-42716-01

Serial No.: 09/466,807

Applicant(s): DePoorter et al

Filing Date: October 2, 2000

Group: \*

**U.S. PATENT DOCUMENTS**

Examiner Initials		Document Number	Date	Name	Class	Sub Class	Filing Date If Appropriate
<i>M. R.</i>	1.	4,119,267	10/10/78	Kydonieus	229	53	08/18/76
<i>R. P.</i>	2.	4,120,716	10/17/78	Bonet	156	272	06/03/77
<i>M. R.</i>	3.	4,136,205	06/23/79	Quattlebaum	426	412	03/30/77
<i>M. R.</i>	4.	4,239,111	12/16/80	Conant et al	206	484	05/21/79
<i>M. P.</i>	5.	4,267,960	05/19/81	Lind et al	229	55	08/29/79
<i>M. P.</i>	6.	4,302,565	11/24/81	Goeke et al	526	88	02/16/79
<i>M. P.</i>	7.	4,302,566	11/24/81	Karol et al	526	125	02/27/79
<i>M. R.</i>	8.	4,534,984	08/13/85	Kuehne	426	412	08/16/83
<i>M. R.</i>	9.	4,539,236	09/03/85	Vilutis	428	35	01/26/84
<i>M. R.</i>	10.	4,755,403	07/05/88	Ferguson	428	35	07/05/88
<i>M. P.</i>	11.	4,801,486	01/31/89	Quacquarella et al	428	34.9	09/26/86
<i>M. R.</i>	12.	4,879,430	11/07/89	Hoffman	428	35.1	05/14/87
<i>M. P.</i>	13.	4,890,936	01/02/90	Cooper	383	109	05/03/88
<i>M. P.</i>	14.	5,020,922	06/04/91	Schirmer	383	119	03/06/86
<i>M. P.</i>	15.	5,272,236	12/21/93	Lai et al	526	348.5	10/15/91
<i>M. R.</i>	16.	5,278,272	01/11/94	Lai et al	526	348.5	09/02/92
<i>M. P.</i>	17.	5,302,402	04/12/94	Dudenhoeffer et al	426	129	04/12/94
<i>M. R.</i>	18.	5,545,419	08/13/96	Brady et al	426	129	08/13/96

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	Class	Sub-Class	Translation	
							Yes	No
<i>M. R.</i>	1.	0 151 489	08/14/85	EPO				
<i>M. P.</i>	2.	0 512 740 A2 -	11/11/92	EPO				
<i>M. P.</i>	3.	2 074 128 -	10 28 81	GB				
<i>M. P.</i>	4.	2 291 402 A -	01/24/98	GB				
<i>M. P.</i>	5.	230 362 -	08/18/89	NZ				
<i>M. P.</i>	6.	- 236 317 -	12/03/90	NZ				
<i>M. P.</i>	7.	- 236 523 -	12/18/90	NZ				
<i>M. P.</i>	8.	925 035 -	05 01 63	SE				
<i>M. P.</i>	9.	96/00688 -	01/11/96	WO				
<i>M. P.</i>	10.	90/03414 -	04/05/90	WO				

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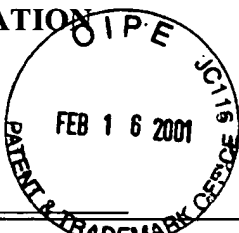
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**OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)**

1.

Determination of Branching Distributions in Polyethylene and Ethylene Copolymers, Journal of Polymer Science: Polymer Physics Edition, Vol. 20, Pgs. 441-455 (1982), John Wiley &amp; Sons.

m.p.

EXAMINER

Date Considered

Mark Patterson

7/23/02

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**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	Class	Sub- Class	Translation	
							Yes	No
M.P.	1. ✓	134899	09/06/65	NZ				
M.P.	2. ✓	152723	01/20/71	NZ				

**OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)**


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*Man Pitterman*
*1/23/02*

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<i>M.R.</i>	1.	3,383,746	05/21/68	Narduzzi et al	029	33.5	09/22/65
<i>M.R.</i>	2.	3,352,090	01/05/71	Roberts et al	053	071	09/11/67
<i>M.R.</i>	3.	3,628,576	12/21/71	Owen	141	065	07/25/69
<i>M.R.</i>	4.	4,064,296	12/20/77	Bornstein et al	428	035	10/02/75
<i>M.R.</i>	5.	4,278,738	07/14/81	Brax et al	428	515	07/16/79
<i>M.R.</i>	6.	5,206,075	04/27/93	Hodgson, Jr.	428	216	12/19/91
<i>M.R.</i>	7.	5,241,031	08/31/93	Mehta	526	348.1	02/19/92
<i>M.R.</i>	8.	5,376,394	12/27/94	Dudenhoeffer et al	426	415	12/27/94

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		Document Number	Date	Country	Class	Sub- Class	Translation	
							Yes	No
<i>M.R.</i>	1.	93/03093	02/18/93	PCT				

**OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)**

<i>M.R.</i>	1.		Standard Test Method for Unrestrained Linear Thermal Shrinkage of Plastic Film and Sheeting, ASTM D-2732, Pages 368-371, Sept. 1989.					

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*Man Patterson**7/23/02*

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